Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
1	10/757,192	DEWITT ET AL.	
	Examiner	Art Unit	
	Raymond Phan	2111	

SEARCHED						
Class	Subclass	Date	Examiner			
710	260-269	5/20/2006	RP			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST	5/22/2006	RP			